



SEMITRANS™ 4

## IGBT Modules

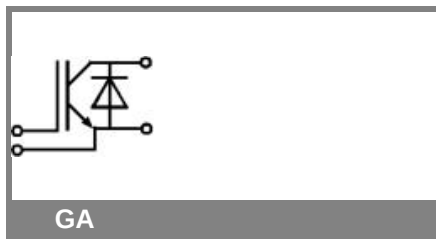
### SKM 400GA123D

#### Features

- MOS input (voltage controlled)
- N channel, homogeneous Si
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to  $6 \times I_{Cnom}$
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DBC Direct Copper Bonding Technology
- Large clearance (12 mm) and creepage distances (20 mm)

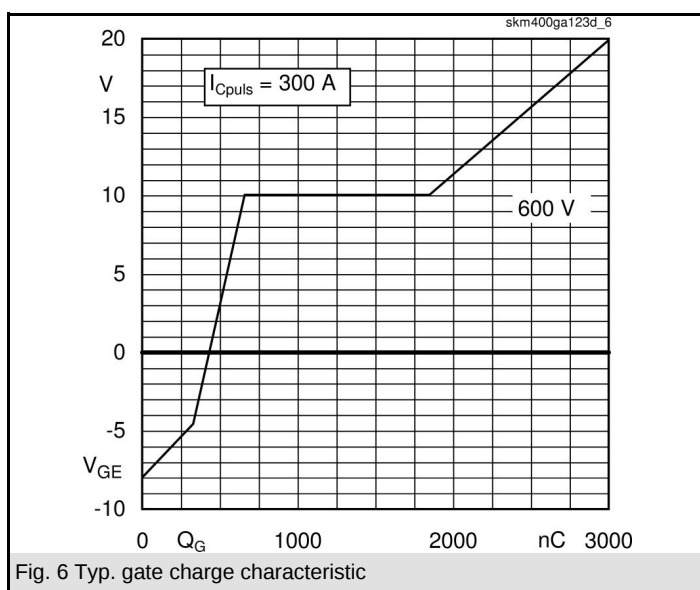
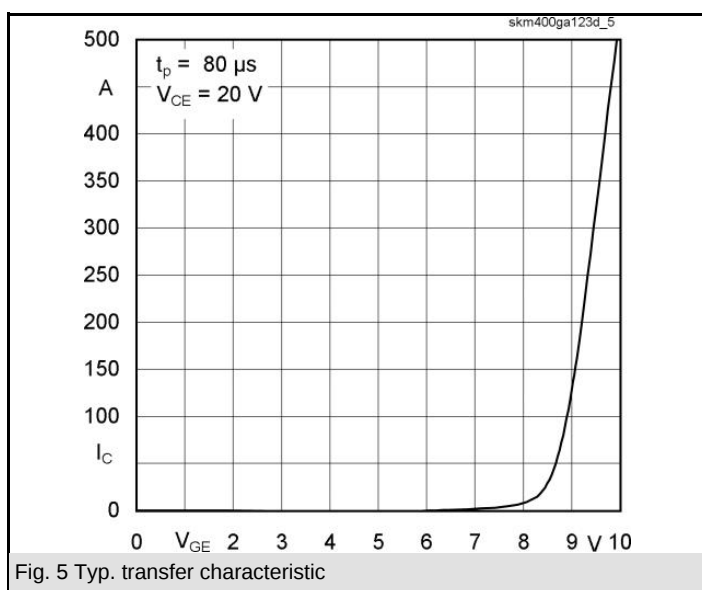
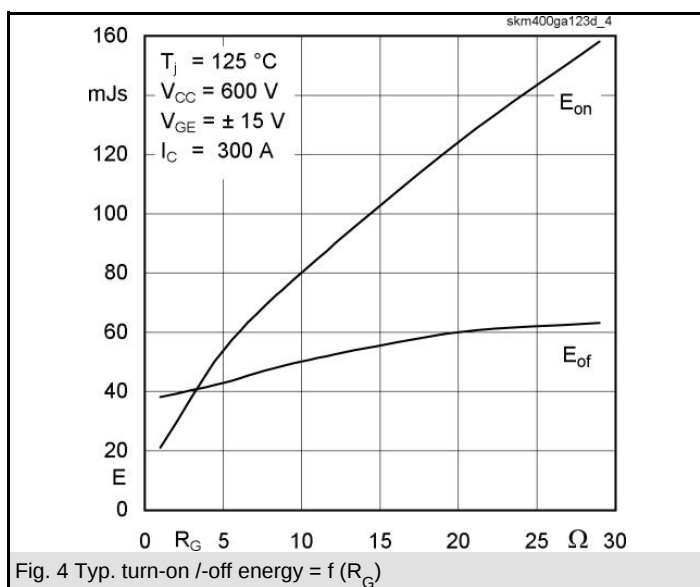
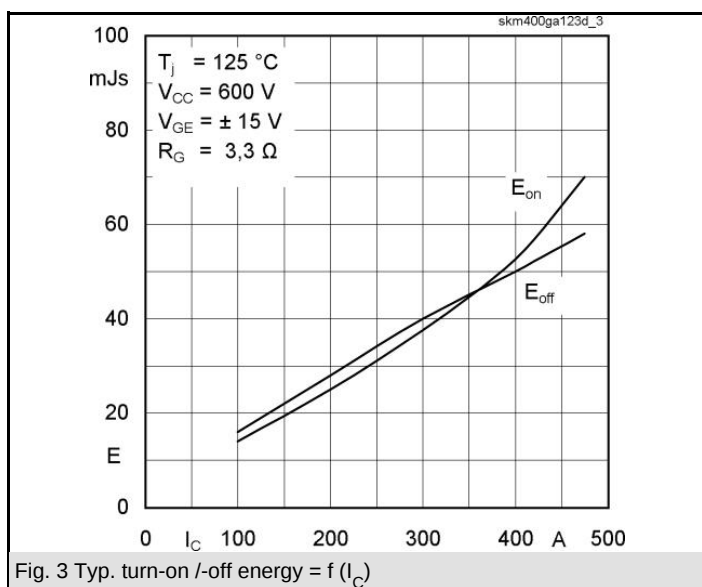
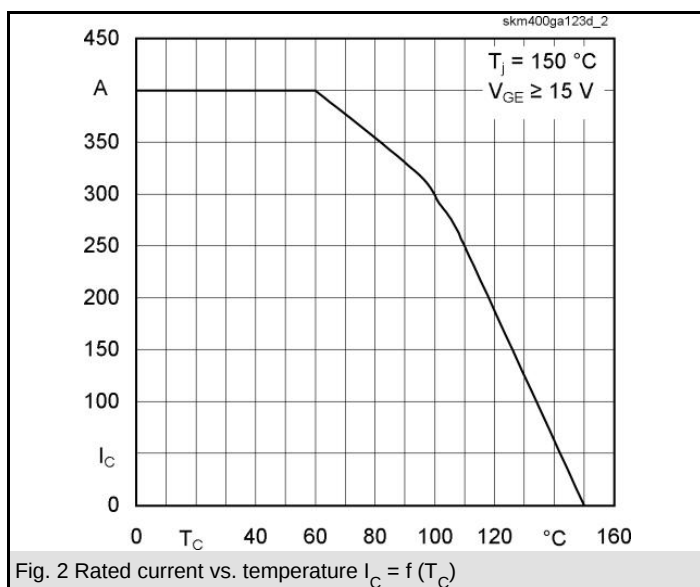
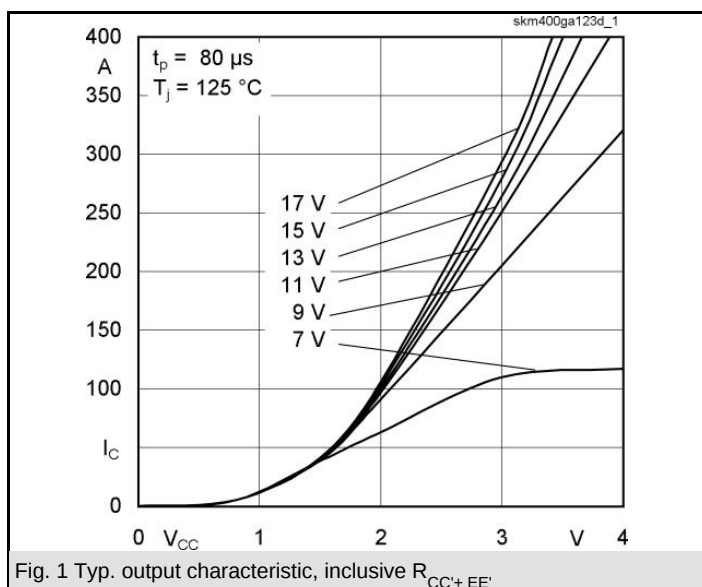
#### Typical Applications

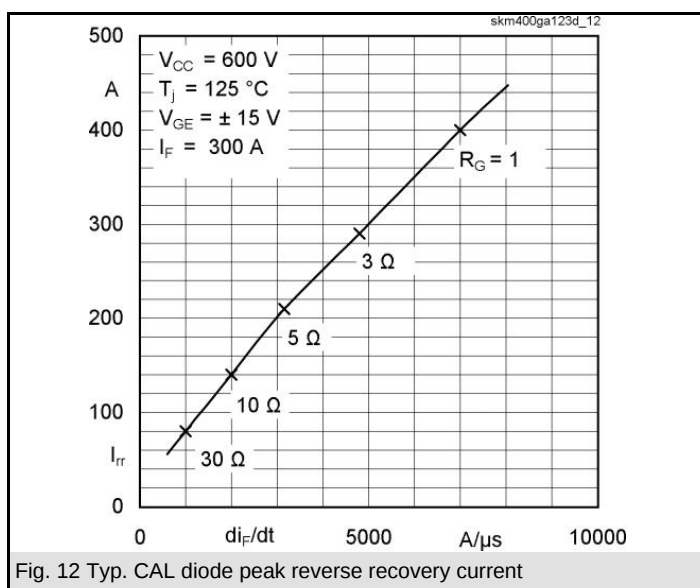
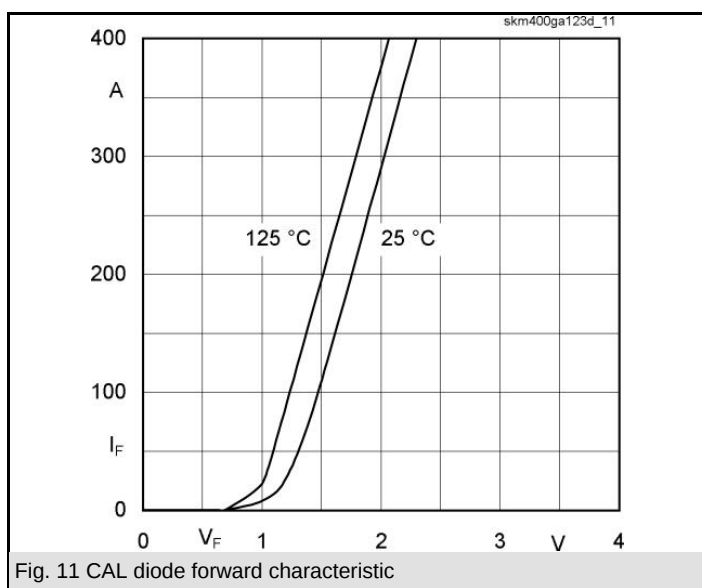
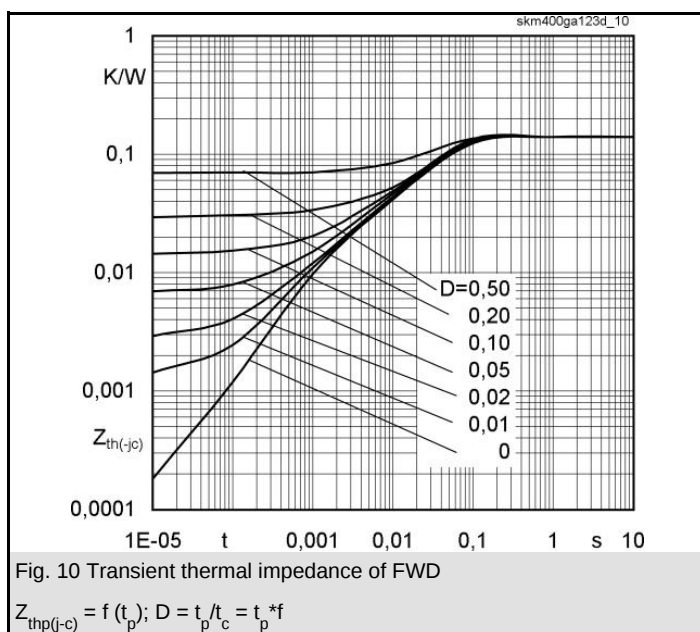
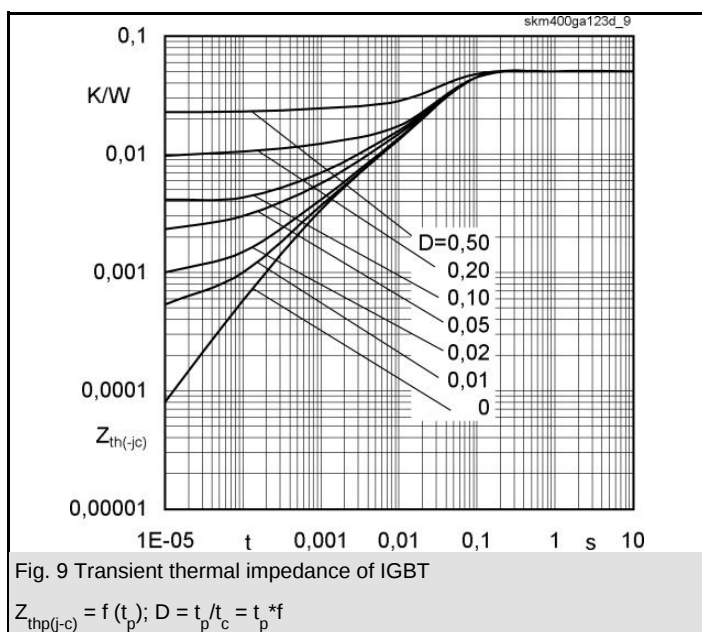
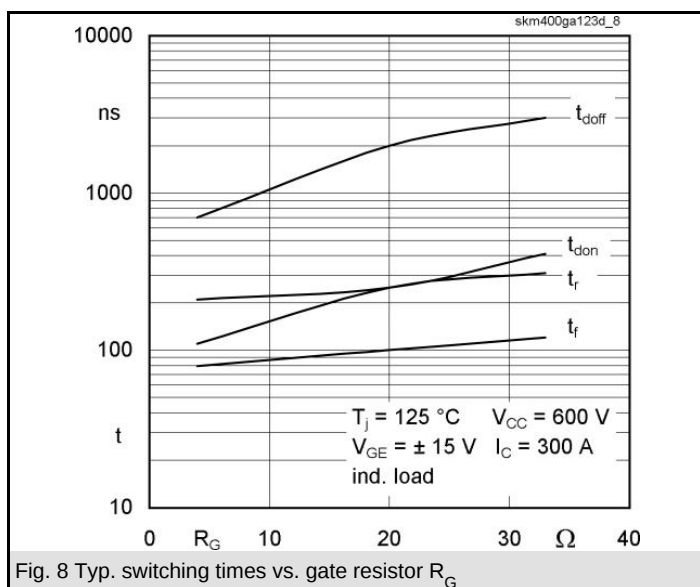
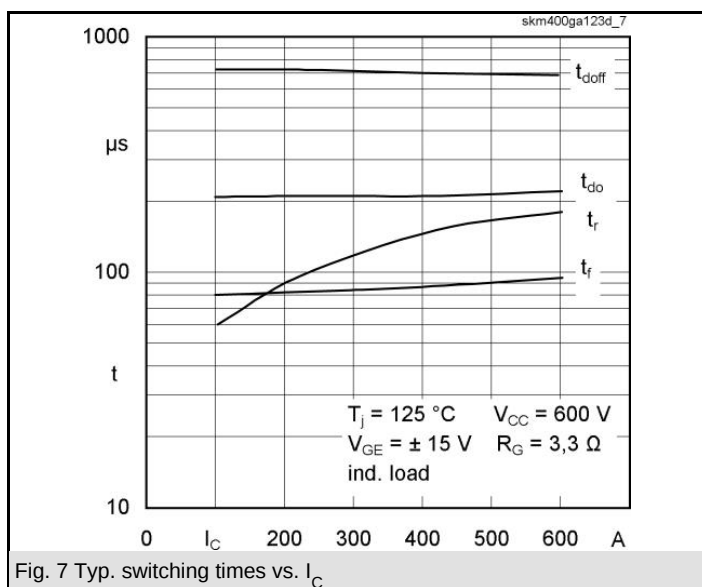
- Switching (not for linear use)

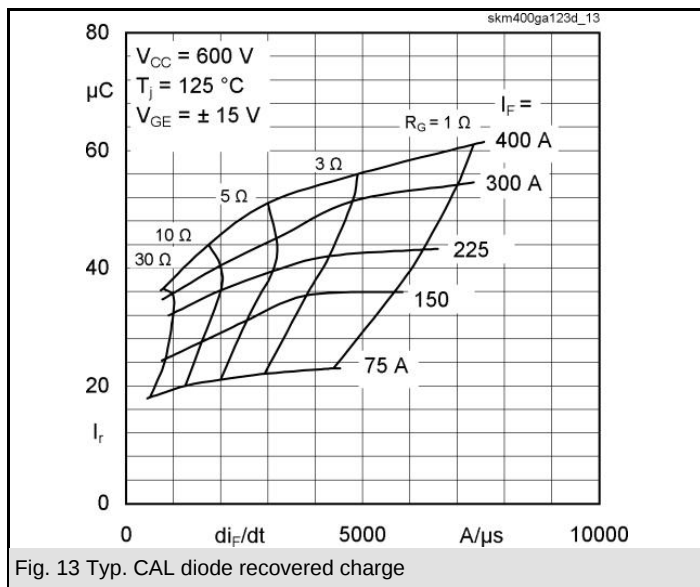


| Absolute Maximum Ratings |                                                         | $T_c = 25^\circ\text{C}$ , unless otherwise specified |                  |
|--------------------------|---------------------------------------------------------|-------------------------------------------------------|------------------|
| Symbol                   | Conditions                                              | Values                                                | Units            |
| <b>IGBT</b>              |                                                         |                                                       |                  |
| $V_{CES}$                |                                                         | 1200                                                  | V                |
| $I_C$                    | $T_c = 25 (80)^\circ\text{C}$                           | 400 (360)                                             | A                |
| $I_{CRM}$                | $t_p = 1 \text{ ms}$                                    | 600                                                   | A                |
| $V_{GES}$                |                                                         | $\pm 20$                                              | V                |
| $T_{vj}$ ( $T_{stg}$ )   | $T_{OPERATION} \leq T_{stg}$                            | - 40 ... + 150 (125)                                  | $^\circ\text{C}$ |
| $V_{isol}$               | AC, 1 min.                                              | 2500                                                  | V                |
| <b>Inverse diode</b>     |                                                         |                                                       |                  |
| $I_F$                    | $T_c = 25 (80)^\circ\text{C}$                           | 390 (260)                                             | A                |
| $I_{FRM}$                | $t_p = 1 \text{ ms}$                                    | 600                                                   | A                |
| $I_{FSM}$                | $t_p = 10 \text{ ms}$ ; sin.; $T_j = 150^\circ\text{C}$ | 2900                                                  | A                |

| Characteristics                |                                                                                      | $T_c = 25^\circ\text{C}$ , unless otherwise specified |             |             |               |
|--------------------------------|--------------------------------------------------------------------------------------|-------------------------------------------------------|-------------|-------------|---------------|
| Symbol                         | Conditions                                                                           | min.                                                  | typ.        | max.        | Units         |
| <b>IGBT</b>                    |                                                                                      |                                                       |             |             |               |
| $V_{GE(th)}$                   | $V_{GE} = V_{CE}$ , $I_C = 12 \text{ mA}$                                            | 4,5                                                   | 5,5         | 6,5         | V             |
| $I_{CES}$                      | $V_{GE} = 0$ , $V_{CE} = V_{CES}$ , $T_j = 25 (125)^\circ\text{C}$                   |                                                       | 0,1         | 0,3         | mA            |
| $V_{CE(TO)}$                   | $T_j = 25 (125)^\circ\text{C}$                                                       |                                                       | 1,4 (1,6)   | 1,6 (1,8)   | V             |
| $r_{CE}$                       | $V_{GE} = 15 \text{ V}$ , $T_j = 25 (125)^\circ\text{C}$                             |                                                       | 3,66 (5)    | 4,66 (6,33) | m $\Omega$    |
| $V_{CE(sat)}$                  | $I_{Cnom} = 300 \text{ A}$ , $V_{GE} = 15 \text{ V}$ , chip level                    |                                                       | 2,5 (3,1)   | 3 (3,7)     | V             |
| $C_{ies}$                      | under following conditions                                                           |                                                       | 22          | 30          | nF            |
| $C_{oes}$                      | $V_{GE} = 0$ , $V_{CE} = 25 \text{ V}$ , $f = 1 \text{ MHz}$                         |                                                       | 3,3         | 4           | nF            |
| $C_{res}$                      |                                                                                      |                                                       | 1,2         | 1,6         | nF            |
| $L_{CE}$                       |                                                                                      |                                                       |             | 20          | nH            |
| $R_{CC'+EE'}$                  | res., terminal-chip $T_c = 25 (125)^\circ\text{C}$                                   |                                                       | 0,18 (0,22) |             | m $\Omega$    |
| $t_{d(on)}$                    | $V_{CC} = 600 \text{ V}$ , $I_{Cnom} = 300 \text{ A}$                                |                                                       | 200         | 400         | ns            |
| $t_r$                          | $R_{Gon} = R_{Goff} = 3,3 \Omega$ , $T_j = 125^\circ\text{C}$                        |                                                       | 115         | 220         | ns            |
| $t_{d(off)}$                   | $V_{GE} = \pm 15 \text{ V}$                                                          |                                                       | 720         | 900         | ns            |
| $t_f$                          |                                                                                      |                                                       | 80          | 100         | ns            |
| $E_{on} (E_{off})$             |                                                                                      |                                                       | 38 (40)     |             | mJ            |
| <b>Inverse diode</b>           |                                                                                      |                                                       |             |             |               |
| $V_F = V_{EC}$                 | $I_{Fnom} = 300 \text{ A}$ ; $V_{GE} = 0 \text{ V}$ ; $T_j = 25 (125)^\circ\text{C}$ |                                                       | 2 (1,8)     | 2,5         | V             |
| $V_{(TO)}$                     | $T_j = 125 ( )^\circ\text{C}$                                                        |                                                       |             | 1,2         | V             |
| $r_T$                          | $T_j = 125 ( )^\circ\text{C}$                                                        |                                                       | 2,5         | 3,5         | m $\Omega$    |
| $I_{RRM}$                      | $I_{Fnom} = 300 \text{ A}$ ; $T_j = 25 ( 125 )^\circ\text{C}$                        |                                                       | 85 (140)    |             | A             |
| $Q_{rr}$                       | $di/dt = 2000 \text{ A}/\mu\text{s}$                                                 |                                                       | 13 (40)     |             | $\mu\text{C}$ |
| $E_{rr}$                       | $V_{GE} = V$                                                                         |                                                       |             |             | mJ            |
| <b>Thermal characteristics</b> |                                                                                      |                                                       |             |             |               |
| $R_{th(j-c)}$                  | per IGBT                                                                             |                                                       |             | 0,045       | K/W           |
| $R_{th(j-c)D}$                 | per Inverse Diode                                                                    |                                                       |             | 0,125       | K/W           |
| $R_{th(c-s)}$                  | per module                                                                           |                                                       |             | 0,038       | K/W           |
| <b>Mechanical data</b>         |                                                                                      |                                                       |             |             |               |
| $M_s$                          | to heatsink M6                                                                       | 3                                                     |             | 5           | Nm            |
| $M_t$                          | to terminals M6, M4                                                                  | 2,5                                                   |             | 5           | Nm            |
| w                              |                                                                                      |                                                       |             | 330         | g             |



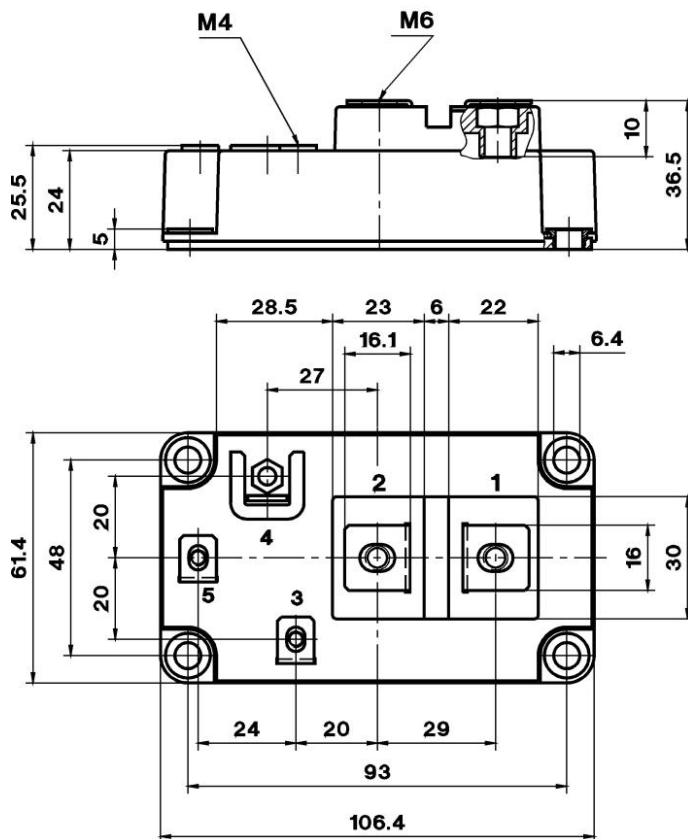




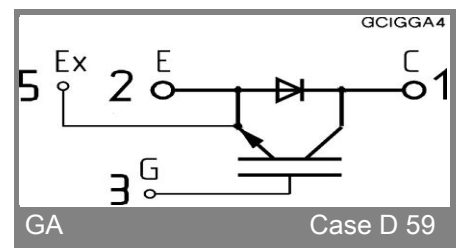
UL Recognized  
File no. E 63 532

Dimensions in mm

CASED59



Case D 59



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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